

UNIVERSITÄT BERN

# Machine Learning Review

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#### Contents

Revision of basic concepts of Machine Learning

• Based on Chapter 5 of Deep Learning by Goodfellow, Bengio, Courville

#### Context

- A more complete introduction to Machine Learning through the following courses
  - Machine Learning @ UniBe
  - Machine Learning and Data Mining @ UniNe
  - Pattern Recognition @ UniFr
  - Statistical Learning Methods @ UniNe

#### Resources

- Books and online material for further studies
  - Machine Learning @ Stanford (Andrew Ng)
  - Pattern Recognition and Machine Learning by Christopher M. Bishop
  - Machine Learning: a Probabilistic Perspective by Kevin P. Murphy

## Learning Pillars

- Supervised learning
- Semi-supervised learning
- Self-taught learning (unsupervised feature learning)
- Unsupervised learning
- Reinforcement learning

#### Definition

Mitchell (1997)
 A computer program is said to learn from experience E with respect to some class of tasks T and performance measure P, if its performance at tasks in T, as measured by P, improves with experience E.

## The Task T

- Example: if we want a robot to be able to walk, then walking is the task
- Approaches
  - 1. We could directly input directives for how we think a robot should walk, or
  - 2. We could provide examples of successful and unsuccessful walking (this is machine learning)

## The Task T

- Given an input x (e.g., a vector) produce a function f, such that f(x) = y (e.g., an integer, a probability vector)
- Examples
  - Classification
  - Regression
  - Machine translation
  - Denoising
  - Probability density estimation

#### The Performance Measure P

- To evaluate a ML algorithm we need a way to measure how well it performs on the task
- It is measured on a separate set (the test set) from what we use to build the function f (the training set)
- Examples
  - Classification accuracy (portion of correct answers) or error rate (portion of incorrect answers)
  - Regression accuracy (e.g., least squares errors)

## The Experience E

- Specifies what data can be used to solve the task
- We can distinguish it based on the learning pillars
  - **Supervised**: data is composed of both the input x (e.g., features) and output y (e.g., labels/targets)
  - Unsupervised: data is composed of just x; here we typically aim for p(x) or a
    method to sample p(x)
  - Reinforcement: data is dynamically gathered based on previous experience

#### Data

- We assume that all collected data samples in all datasets:
  - 1. come from the same distribution

$$-p_{x^{(i)}}(x) = p_{x^{(j)}}(x)$$

2. are independent

$$\longrightarrow p\left(x^{(1)}, \dots, x^{(m)}\right) = \prod_{i=1}^{m} p\left(x^{(i)}\right)$$

This assumption is denoted IID (independent and identically distributed)

## Overfitting and Underfitting

• Performance P captures how well the learned model predicts new unseen data

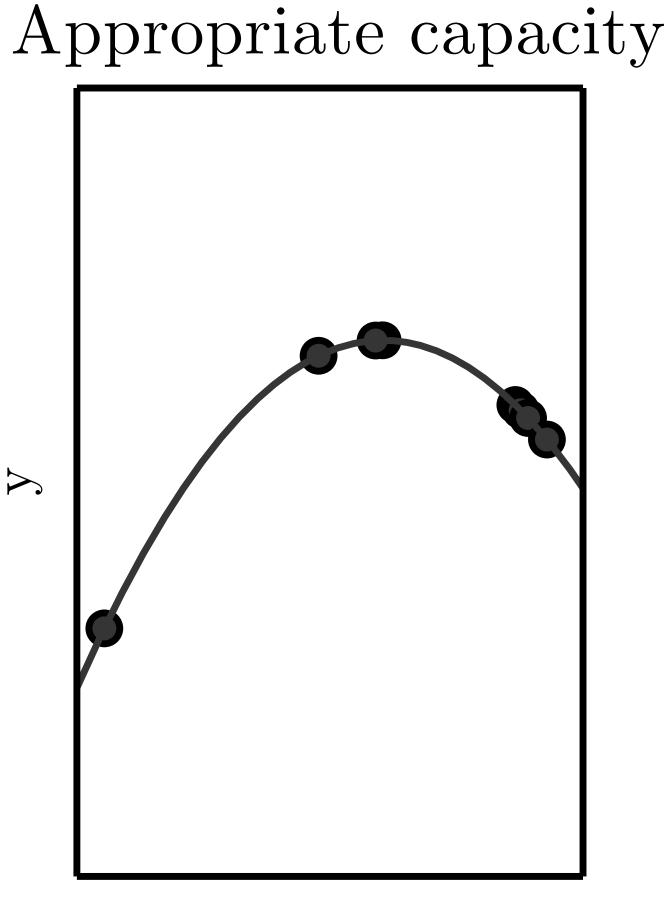
Ideally we want to select the predictor with the best performance

What happens when we use predictors of different complexity/capacity?

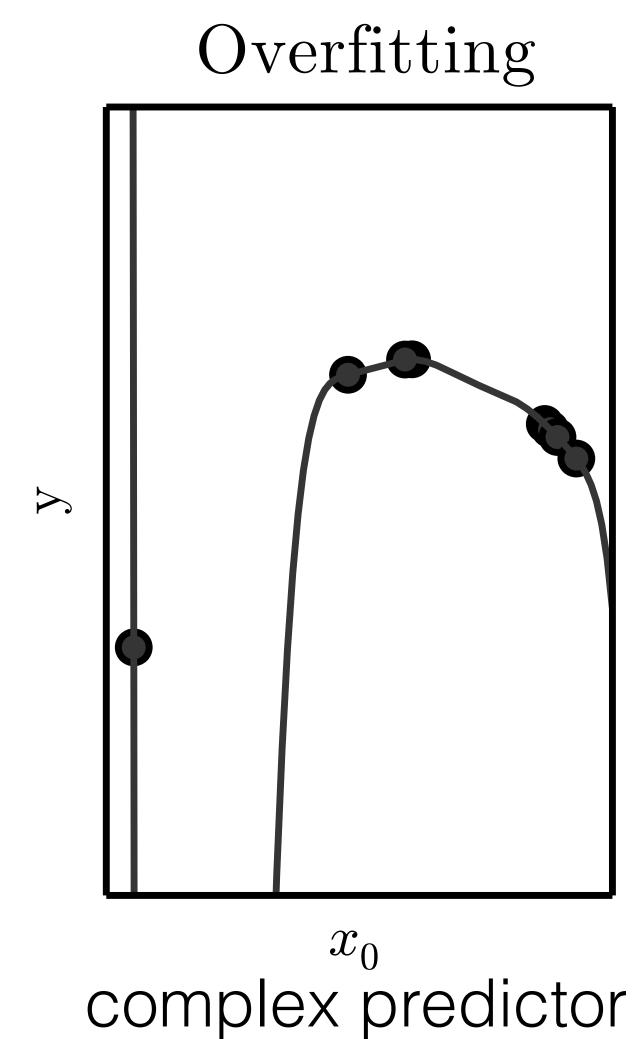
## Overfitting and Underfitting

Underfitting shown data is the training set

simple predictor



optimal predictor



#### Loss function

- Define a **predictor** function  $f: \mathcal{X} \mapsto \mathcal{Y}$
- Define a **loss** function  $l: \mathcal{Y} \times \mathcal{Y} \mapsto \mathbb{R}$  which measures how different the two inputs are
- Examples

• 0-1 loss 
$$l(y,f(x)) = \begin{cases} 0 \text{ if } y = f(x) \\ 1 \text{ if } y \neq f(x) \end{cases}$$

• Quadratic loss  $l(y, f(x)) = (y - f(x))^2$ 

## Bayes Risk

• Bayes risk is defined as (average loss)

$$R(f) = E_{x,y}[l(f(x), y)] = \int l(f(x), y)p(x, y)dxdy$$

• The optimal predictor function is

$$f^* = \arg\min_{f} R(f)$$

## Empirical Risk

• Given  $(x_i,y_i)$  with i=1,...,m the **empirical risk** is

$$\hat{R}(f) = \frac{1}{m} \sum_{i=1}^{m} l(f(x_i), y_i)$$

The empirical predictor is

$$\hat{f} = \arg\min_{f \in \mathcal{F}} \hat{R}(f)$$

## Training, Validation and Test

- In alternative, collect samples into training set  $D_{
  m train}$ , validation set  $D_{
  m val}$  and test set  $D_{
  m test}$
- Use the training set to define the optimal predictor

$$\hat{f}_{\lambda} = \arg\min_{f \in \mathcal{F}} \hat{R}_{D_{\text{train}}}(f)$$

• Use the validation set to choose the capacity

$$\hat{\lambda} = \arg\min_{\lambda} \hat{R}_{D_{\text{val}}}(\hat{f}_{\lambda})$$

• Use the **test set** to evaluate the performance

performance 
$$P = R_{D_{\text{test}}} \left( \hat{f}_{\hat{\lambda}} \right)$$

#### Maximum Likelihood

- Given IID data samples  $x^1, \dots, x^m \sim p_{\text{data}}(x)$
- Let  $p_{model}(x;\theta)$  be a parametric family of probability density functions
- The maximum likelihood estimator of  $\, heta\,$  is

$$\theta_{\text{ML}} = \arg \max_{\theta} \prod_{i=1}^{m} p_{\text{model}}(x^{i}; \theta)$$

$$= \arg \max_{\theta} \sum_{i=1}^{m} \log p_{\text{model}}(x^{i}; \theta)$$

$$= \arg \max_{\theta} E_{x \sim \hat{p}_{\text{data}}} [\log p_{\text{model}}(x; \theta)]$$

with the empirical data distribution  $\hat{p}_{\mathrm{data}}(x)$ 

## Maximum Likelihood

• Maximum likelihood estimation can also be interpreted as fitting  $p_{\text{model}}(x;\theta)$  to  $p_{\text{data}}(x)$  via a Kullback-Leibler divergence minimization

$$\begin{split} & \arg\max_{\theta} -D_{\mathrm{KL}}(\hat{p}_{\mathrm{data}}|p_{\mathrm{model}}) \\ & = \arg\max_{\theta} -E_{x \sim \hat{p}_{\mathrm{data}}}[\log\hat{p}_{\mathrm{data}}(x) - \log p_{\mathrm{model}}(x;\theta)] \\ & = \arg\max_{\theta} E_{x \sim \hat{p}_{\mathrm{data}}}[\log p_{\mathrm{model}}(x;\theta)] \end{split}$$

#### Maximum Likelihood

• Given IID input/output samples  $(x^i,y^i) \sim p_{\mathrm{data}}(x,y)$ 

the conditional maximum likelihood estimate is

$$\theta_{\text{ML}} = \arg \max_{\theta} \prod_{i=1}^{m} p_{\text{data}}(y^{i}|x^{i};\theta)$$

$$= \arg \max_{\theta} \sum_{i=1}^{m} \log p_{\text{data}}(y^{i}|x^{i};\theta)$$

#### Maximum a Posteriori

- Given IID data samples  $x^1, \dots, x^m \sim p_{\text{data}}(x)$
- Let  $p(x^1, \ldots, x^m | \theta)$  be the conditional probability density function
- Maximum a Posteriori aims at recovering

$$p(\theta|x^1,\ldots,x^m) = \frac{p(x^1,\ldots,x^m|\theta)p(\theta)}{p(x^1,\ldots,x^m)}$$

#### Maximum a Posteriori

- The prior  $p(\theta)$  can encode a preference for simpler or smoother models (acts as regularizer)
- Predictions could be obtained by marginalizing over the parameters (this corresponds to a quadratic loss function in Bayes risk)

$$p(x^{m+1}|x^1,\ldots,x^m) = \int p(x^{m+1}|\theta)p(\theta|x^1,\ldots,x^m)d\theta$$

#### Maximum a Posteriori

• If we minimize Bayes risk with a 0-1 loss function, we obtain a point estimate

$$\theta_{\text{MAP}} = \arg \max_{\theta} p(\theta|x) = \arg \max_{\theta} \log p(x|\theta) + \log p(\theta)$$

which is computationally feasible.

• This is the Maximum a Posteriori (MAP) estimate

## Supervised Learning

- Make a prediction of an output y given an input x
- Boils down to determining the conditional probability

• Formulate problem as that of finding  $\,\theta\,$  for a parametric family (Maximum Likelihood)

$$p(y|x;\theta)$$

# Supervised Learning

- **Example**: Binary classification  $y \in \{0, 1\}$
- We aim at determining  $p(y=1|x;\theta)=\sigma(\theta^{\top}x)$

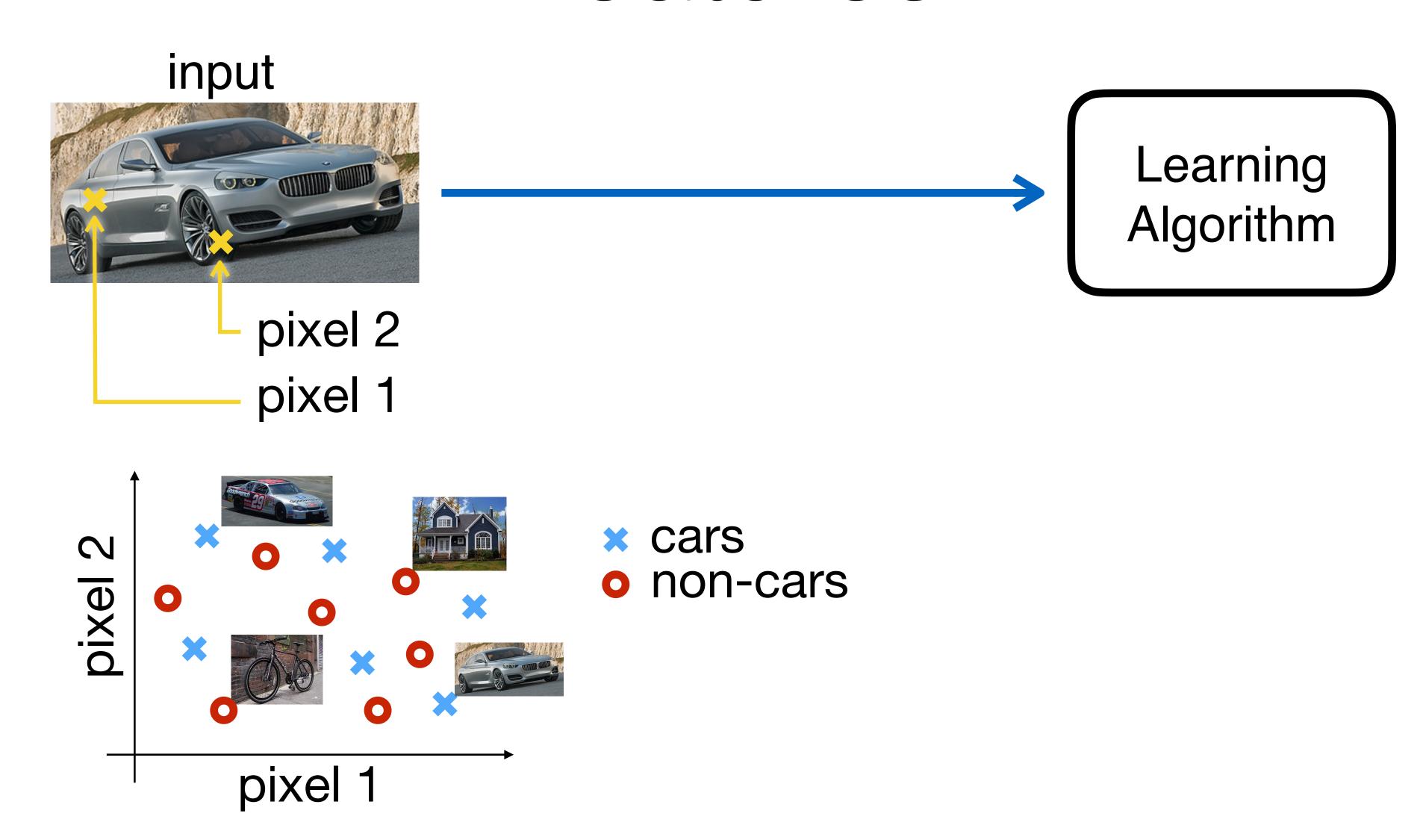
where 
$$\sigma(z) = \frac{1}{1 + e^{-z}}$$
 is the sigmoid function

Class y=1 can be picked when

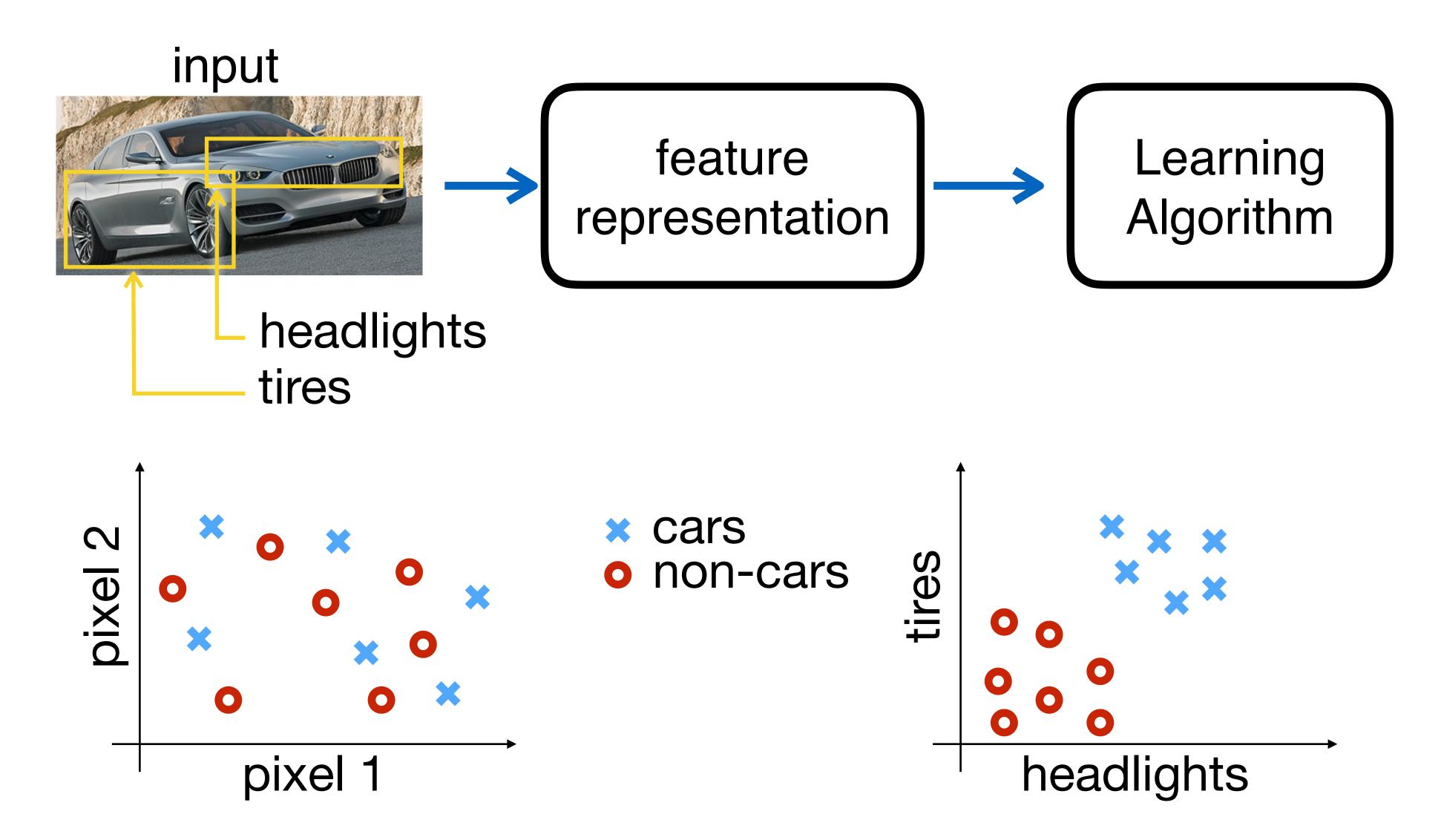
$$p(y = 1|x;\theta) > p(y = 0|x;\theta)$$

which is equivalent to  $\theta^{\top}x > 0$ 

## Features



#### Features



## Building a Machine Learning Algorithm

- 1. Build a dataset
- 2. Define a model
- 3. Define a cost function
- 4. Define an optimization procedure

Dataset of cars and non-cars (>1M samples)





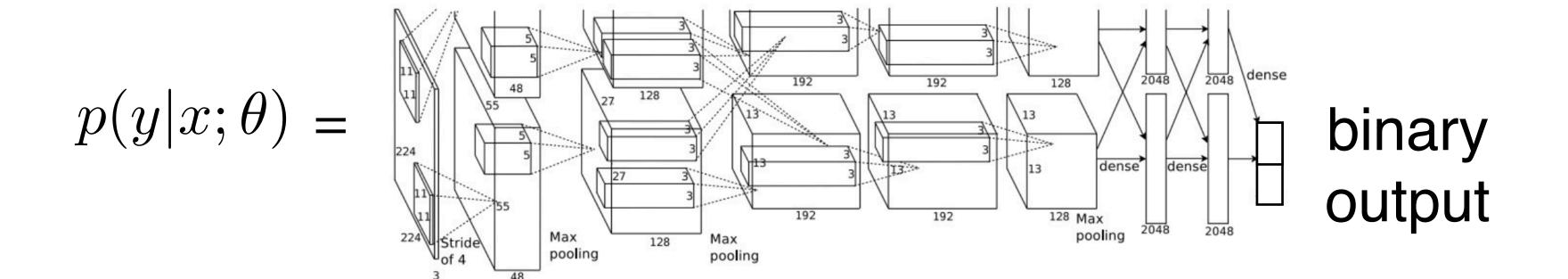




$$y=1$$
 (cars)

$$y = 1$$
 (cars)  $y = 0$  (non-cars)

#### Model



convolutional neural network

#### Cost function

$$\sum_{i=1}^{m} \log p(y^{i}|x^{i};\theta)$$

negative cross entropy (maximum likelihood)

#### Optimization procedure

$$\theta_{t+1} = \theta_t + \alpha_t \frac{\nabla_{\theta} p(y^i | x^i; \theta_t)}{p(y^i | x^i; \theta_t)} \qquad i \sim U[1, m]$$

stochastic gradient ascent